

Notice of References Cited

Application/Control No.

09/873,815

Applicant(s)/Patent Under
Reexamination
LAVORGNA ET AL.

Examiner

Tan Dean D. Nguyen

Art Unit

3689

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,381,579	04-2002	Gervais et al.	705/8
*	B	US-2002/0122422	09-2002	Kenney et al.	370/392
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

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